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# Dynamic Behavior of Nonlinear Power Amplifiers in Stable and Injection-Locked Modes

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**Abstract**—Dynamic equations of reflection-type nonlinear power amplifiers in both stable and injection-locked modes are derived for modulated signals. The steady-state response and the transient response of an injection-locked negative-resistance diode amplifier is evaluated. The response for an FM signal is discussed. Numerical results show that the dynamic behavior as well as the steady-state behavior is affected by nonlinearity of the diode conductance and susceptance.

## INTRODUCTION

MICROWAVE power amplifiers, including injection-locked ones, using new negative-resistance diodes such as IMPATT diodes and Gunn effect diodes, have been investigated in recent years. Steady-state single-frequency responses of nonlinear power amplifiers in both stable<sup>1</sup> and injection-locked modes have been investigated theoretically and experimentally by several authors [1]–[3]. Nonlinear effects are expected not only in the steady-state behavior but also in the dynamic behavior. The dynamic behavior of injection-locked oscillators or amplifiers was studied, so far, following Adler's theory [4]. More recently, Kuno *et al.* [5] have presented amplitude and phase equations evolved by using the nonlinear instantaneous voltage-controlled device model.

The present purpose is to investigate nonlinear admittance effects on both steady-state and dynamic behaviors of nonlinear power amplifiers. Dynamic equations for reflection-type nonlinear power amplifiers in

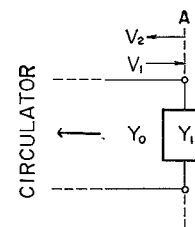


Fig. 1. Reflection-type amplifier diagram.

both stable and injection-locked modes were derived for modulated signals by extending the results evolved from the method of expansion of the injection-locked oscillator admittance [2], [6]–[8]. The steady-state responses and the transient responses of an injection-locked amplifier were evaluated by sample calculations on the simplified model of a negative-resistance diode amplifier. The response for an FM signal is also discussed.

## DYNAMIC EQUATIONS

The reflection-type amplifier uses a circulator to provide input-output isolation. The basic network used for analysis is shown in Fig. 1, where  $V_1$  and  $V_2$  are the incident and reflected voltage waves at reference plane A. The active network (whose admittance is  $Y_1$ ), including the negative-resistance diode, is connected to a matched circulator through the lossless transmission line with characteristic admittance  $Y_0$ .

$V_1$  and the ac voltage  $V_3$  across  $Y_1$ , which are sinusoidal with slowly varying amplitude and phase, can be expressed by

$$\begin{aligned} V_1 &= \tilde{V}_1(t) e^{j(\omega t + \alpha(t))} \\ V_3 &= \tilde{V}_3(t) e^{j(\omega t + \theta(t))} \end{aligned} \quad (1)$$

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<sup>1</sup> "Stable mode" is amplification mode where oscillation will not occur if undriven.

where  $V_3 = V_1 + V_2$ .  $V_1$  and  $V_3$  satisfy the relation

$$\frac{V_3}{V_1} = \frac{2Y_0}{Y_0 + Y_1}. \quad (2)$$

In (2), assume that  $\tilde{V}_3$  and  $\omega$  are deviated slightly from the steady-state values  $\tilde{V}_{30}$  and  $\omega_1$ , respectively. Then we can express the deviation of the admittance  $Y_1$  as

$$\delta Y = \left( \frac{\partial Y_1}{\partial \omega} \right)_{\omega_1} (\omega - \omega_1) + \left( \frac{\partial Y_1}{\partial \tilde{V}_3} \right)_{\tilde{V}_{30}} (\tilde{V}_3 - \tilde{V}_{30}). \quad (3)$$

From (2), we have

$$V_1 = \frac{1}{2Y_0} [Y_0 + Y_1(\omega_1, \tilde{V}_{30}) + \delta Y] V_3.$$

Replacing  $\omega$  by  $\omega_1 + (d\theta/dt) - j(1/\tilde{V}_3) \cdot (d\tilde{V}_3/dt)$  in (3) [6], [7],

$$\frac{\tilde{V}_1}{\tilde{V}_3} e^{-j(\theta-\alpha)} = \frac{Y_0 + Y_1(\omega_1, \tilde{V}_{30})}{2Y_0} + \frac{1}{2Y_0} \cdot \left\{ \left( \frac{\partial Y_1}{\partial \omega} \right) \left( \frac{d\theta}{dt} - j \frac{1}{\tilde{V}_3} \cdot \frac{d\tilde{V}_3}{dt} \right) + \left( \frac{\partial Y_1}{\partial \tilde{V}_3} \right) \right\} \tilde{V}_3 \quad (4)$$

where  $\delta \tilde{V}_3 = \tilde{V}_3 - \tilde{V}_{30}$ . For the steady-state single-frequency operation,  $\tilde{V}_1 = \tilde{V}_{10}$ ,  $\tilde{V}_3 = \tilde{V}_{30}$ , and  $\theta = \theta_0$ . Then, from (2), we obtain

$$\frac{Y_0 + Y_1(\omega_1, \tilde{V}_{30})}{2Y_0} = \frac{\tilde{V}_{10}}{\tilde{V}_{30}} e^{-j\theta_0}. \quad (5)$$

From (4), we can derive

$$\left( \frac{\partial G_1}{\partial \omega} \right) \frac{d\theta}{dt} + \left( \frac{\partial B_1}{\partial \omega} \right) \frac{1}{\tilde{V}_3} \cdot \frac{d\tilde{V}_3}{dt} = 2Y_0 \left\{ \frac{\tilde{V}_1}{\tilde{V}_3} \cos(\theta - \alpha) - \frac{\tilde{V}_{10}}{\tilde{V}_{30}} \cos \theta_0 \right\} - \left( \frac{\partial G_1}{\partial \tilde{V}_3} \right) \delta \tilde{V}_3 \quad (6)$$

$$\left( \frac{\partial B_1}{\partial \omega} \right) \frac{d\theta}{dt} - \left( \frac{\partial G_1}{\partial \omega} \right) \frac{1}{\tilde{V}_3} \cdot \frac{d\tilde{V}_3}{dt} = 2Y_0 \left\{ -\frac{\tilde{V}_1}{\tilde{V}_3} \sin(\theta - \alpha) + \frac{\tilde{V}_{10}}{\tilde{V}_{30}} \sin \theta_0 \right\} - \left( \frac{\partial B_1}{\partial \tilde{V}_3} \right) \delta \tilde{V}_3 \quad (7)$$

where  $Y_1 = G_1 + jB_1$ .

Equations (6) and (7) are the basic equations of the reflection-type nonlinear amplifier in both stable and injection-locked modes for modulated signals.

#### STEADY-STATE RESPONSES

For steady-state single-frequency operation, the amplification characteristics in the injection-locked mode are calculated as follows.

$Y_1$  is approximated by linear increases of  $G_1$  ( $<0$ ) and  $B_1$  with ac voltage amplitude, and by a linear increase of  $B_1$  with frequency in the vicinity of the free-running operating point; the frequency dependence of  $G_1$  is neglected ( $\partial G_1/\partial \omega = 0$ ). We assume

TABLE I

$V_0 = 12 \text{ V}$
$\omega_0 = 2\pi \times 8.0 \times 10^9 \text{ rad/s}$
$G_0 = 4.8 \text{ mmho}$
$\partial g_1/\partial v = 0.618$
$\partial b_1/\partial v = 0.618$
$\partial b_1/\partial x = 2Q_{ex} > 0$

$$g_1(v) = -1 + \left( \frac{\partial g_1}{\partial v} \right) (v - 1)$$

$$b_1(x, v) = \left( \frac{\partial b_1}{\partial x} \right) (x - 1) + \left( \frac{\partial b_1}{\partial v} \right) (v - 1). \quad (8)$$

Normalized variables are introduced, letting

$$\begin{aligned} v &= \tilde{V}_3/\tilde{V}_0 \\ v_1 &= \tilde{V}_1/\tilde{V}_0 \\ x &= \omega_1/\omega_0 \\ g_1 &= G_1/G_0 \\ b_1 &= B_1/G_0 \end{aligned} \quad (9)$$

where  $\omega_0$ ,  $\tilde{V}_0$ , and  $G_0$  are the free-running frequency, the free-running terminal voltage amplitude, and the load conductance, respectively. Power expressions are obtained by using the relations

$$\begin{aligned} P_1 &= v_1^2 P_0 \\ P_g &= g_1 v^2 P_0 \\ P_0 &= \frac{1}{2} G_0 \tilde{V}_0^2 \end{aligned} \quad (10)$$

where  $P_0$  is the free-running power,  $P_1$  the input power, and  $P_g$  the power generated by the diode. The output power is

$$P_2 = P_1 + P_g. \quad (11)$$

From (5), we obtain

$$\begin{aligned} v_1^2 &= \frac{v^2}{4} [\{1 + g_1(v)\}^2 + \{b_1(x, v)\}^2] \\ \cos \theta_0 &= \frac{1}{2} \left( \frac{v}{v_1} \right) \{1 + g_1(v)\} \\ \sin \theta_0 &= -\frac{1}{2} \left( \frac{v}{v_1} \right) b_1(x, v). \end{aligned} \quad (12)$$

By deriving the decaying conditions of the deviation from (4), we also obtain the conditions for stable locking [2]:

$$\begin{aligned} \left( \frac{\partial b_1}{\partial x} \right) \left\{ v \left( \frac{\partial g_1}{\partial v} \right) + 4 \left( \frac{v_1}{v} \right) \cos \theta_0 \right\} &> 0 \\ v \left\{ \left( \frac{\partial g_1}{\partial v} \right) \cos \theta_0 - \left( \frac{\partial b_1}{\partial v} \right) \sin \theta_0 \right\} + 2 \left( \frac{v_1}{v} \right) &> 0. \end{aligned} \quad (13)$$

The diode and circuit parameters chosen for sample calculations are given in Table I.<sup>2</sup> The results of nu-

<sup>2</sup> These values are reasonable as sample values for X-band IMPATT diode amplifiers [2], [9].

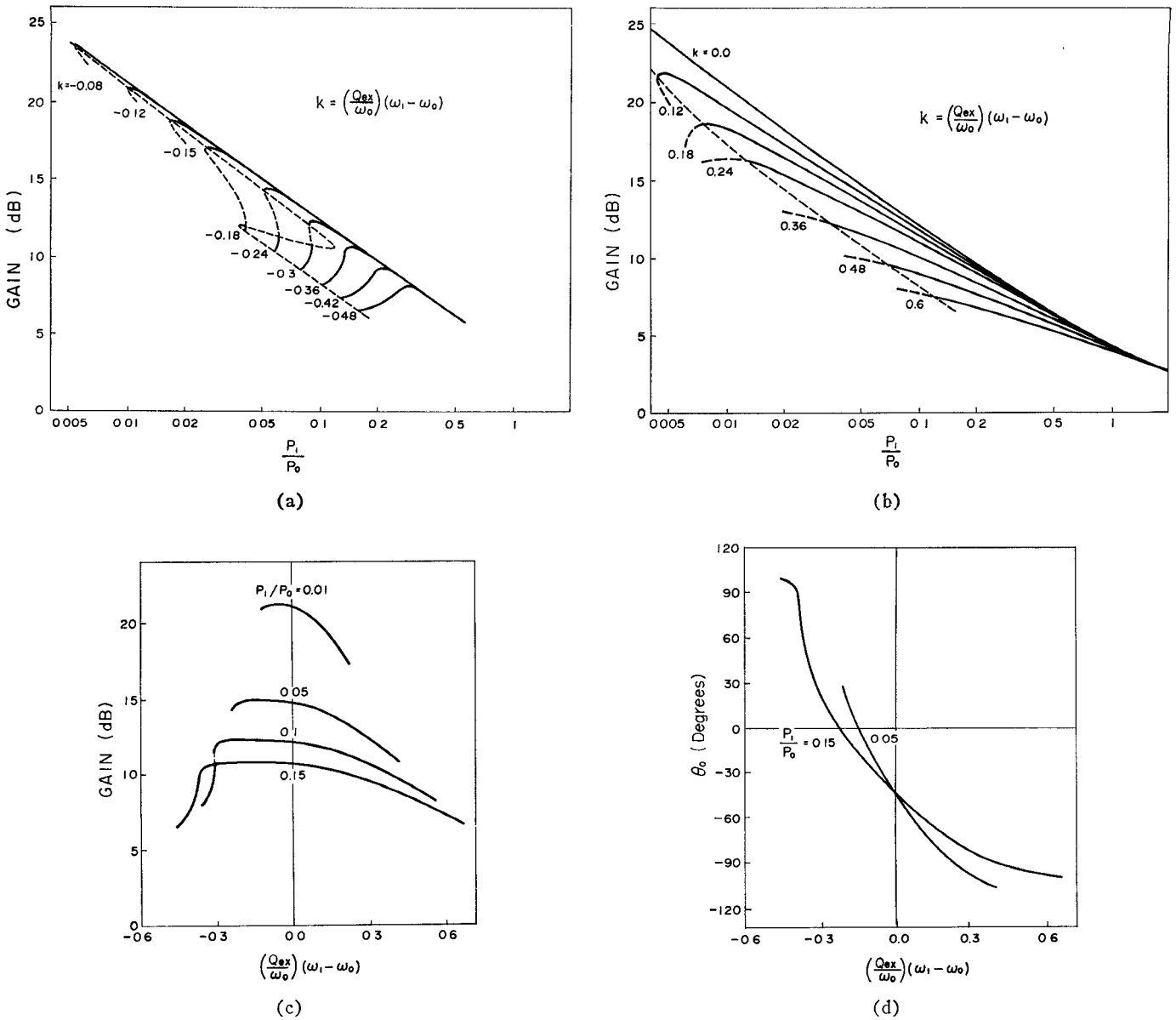


Fig. 2. Injection-locking characteristics. (a), (b) Input-output responses. Gain is the ratio of output power  $P_2$  to input power  $P_1$  in decibels. (c) Frequency responses. (d) Phase of terminal voltage  $V_3$ .

merical calculations using (9)–(13) are given in Fig. 2. Fig. 2(a) and (b) shows input-output responses at several frequencies, Fig. 2(c) shows frequency responses for constant input power levels, and Fig. 2(d) shows the phase of terminal voltage  $V_3$ . Gain is the ratio of output power  $P_2$  to input power  $P_1$  in decibels. The broken lines show unstable operations. Hysteresis phenomena are seen at the lower end of a locking range.

#### RESPONSE FOR AN FM SIGNAL

Modulation conservation rate<sup>3</sup> [10] for an FM signal with small modulation index is derived from (6) and (7) ( $\partial G_1/\partial \omega = 0$ ).

We assume

$$\tilde{V}_1 = \tilde{V}_{10}$$

$$\alpha = m \sin \omega_m t, \quad m \ll 1 \quad (14)$$

$$\theta = \theta_0 + \delta\theta. \quad (15)$$

Using  $|\alpha| \ll 1$ ,  $|\delta\theta| \ll 1$ , and  $\tilde{V}_3 \simeq \tilde{V}_{30}$ ,<sup>4</sup> we get

$$\begin{aligned} \left( \frac{\partial B_1}{\partial \omega} \right) \frac{1}{\tilde{V}_{30}} \frac{d\delta\tilde{V}_3}{dt} + \left( \frac{\partial G_1}{\partial \tilde{V}_3} \right) \delta\tilde{V}_3 \\ = -2Y_0 \frac{\tilde{V}_{10}}{\tilde{V}_{30}} (\delta\theta - \alpha) \sin \theta_0 \end{aligned} \quad (16)$$

$$\left( \frac{\partial B_1}{\partial \omega} \right) \frac{d\delta\theta}{dt} = -2Y_0 \frac{\tilde{V}_{10}}{\tilde{V}_{30}} (\delta\theta - \alpha) \cos \theta_0 - \left( \frac{\partial B_1}{\partial \tilde{V}_3} \right) \delta\tilde{V}_3. \quad (17)$$

<sup>3</sup> This is the ratio of output phase-modulation rate to the input original modulation rate.

<sup>4</sup>  $|\delta\theta| \ll 1$  and  $\tilde{V}_3 \simeq \tilde{V}_{30}$  (or  $|\delta\tilde{V}_3| \ll \tilde{V}_{30}$ ) are compatible with the derived results.

Neglecting the first term in the left-hand side of (16) [where  $(\omega_m/2Y_0)(\partial B_1/\partial\omega) \ll (\tilde{V}_{30}/2Y_0)(\partial G_1/\partial\tilde{V}_3)$  is assumed], we have

$$\delta\tilde{V}_3 = \frac{2Y_0 \left( \frac{\tilde{V}_{10}}{\tilde{V}_{30}} \right)}{\left( \frac{\partial G_1}{\partial \tilde{V}_3} \right)} (m \sin \omega_m t - \delta\theta) \sin \theta_0. \quad (18)$$

Substituting (18) into (17) and expressing  $\delta\theta$  in the form

$$\delta\theta = n \sin(\omega_m t + \phi) \quad (19)$$

we obtain

$$\left( \frac{n}{m} \right)^2 = \frac{1}{1 + \left\{ \frac{\omega_m}{B\sqrt{1+a^2}\cos(\theta_0+\theta_1)} \right\}^2} \quad (20)$$

$$\phi = -\tan^{-1} \left\{ \frac{\omega_m}{B\sqrt{1+a^2}\cos(\theta_0+\theta_1)} \right\} \quad (21)$$

where

$$a = \tan \theta_1 = \frac{\left( \frac{\partial B_1}{\partial \tilde{V}_3} \right)}{\left( \frac{\partial G_1}{\partial \tilde{V}_3} \right)}$$

$$B = \frac{\omega_0}{Q_{\text{ex}}} \left( \frac{\tilde{V}_{10}}{\tilde{V}_{30}} \right)$$

$$Q_{\text{ex}} = \frac{\omega_0}{2Y_0} \left( \frac{\partial B_1}{\partial \omega} \right).$$

From (20), modulation conservation rate  $(n/m)$  is maximum at  $\theta_0 = -\theta_1$ . Phase delay  $\phi$  is also minimum at  $\theta_0 = -\theta_1$ . In the injection-locked mode, from (8) and (12), the condition  $\theta_0 = -\theta_1$  is satisfied at  $\omega_1 = \omega_0$  (or  $x=1$ ). We see that, in spite of the diode susceptance nonlinearity, the optimum frequency condition for an FM signal amplification in the injection-locked mode is satisfied when the injected carrier frequency is equal to the free-running frequency.

#### TRANSIENT RESPONSES

Transient responses for some special cases were obtained by numerically solving (6) and (7). Figs. 3 and 4 show the transient response of the injection-locked amplifier for injected signals with initial phase offset  $\theta_i$  ( $\omega_1 = \omega_0$ ,  $P_1/P_0 = 0.05$ ). Fig. 3(a) shows the amplitude transient response and Fig. 3(b) shows the phase transient response. In the steady state ( $t \rightarrow \infty$ ),  $\theta = -45^\circ$  [see also Fig. 2(d)]. Phase transient overshooting is seen for large negative values of  $\theta_i$ . This is in contrast with the results of Adler's theory [11], which are shown in Fig. 4. Fig. 4 shows the phase transient response for  $\partial B_1/\partial \tilde{V}_3 = 0$ , in comparison with the results of Adler's theory. Fig. 5 shows the transient response for injected signals at various carrier frequencies with step phase shift  $\pi$  at  $t=0$  ( $P_1/P_0 = 0.05$ ). It can be seen that the amplitude

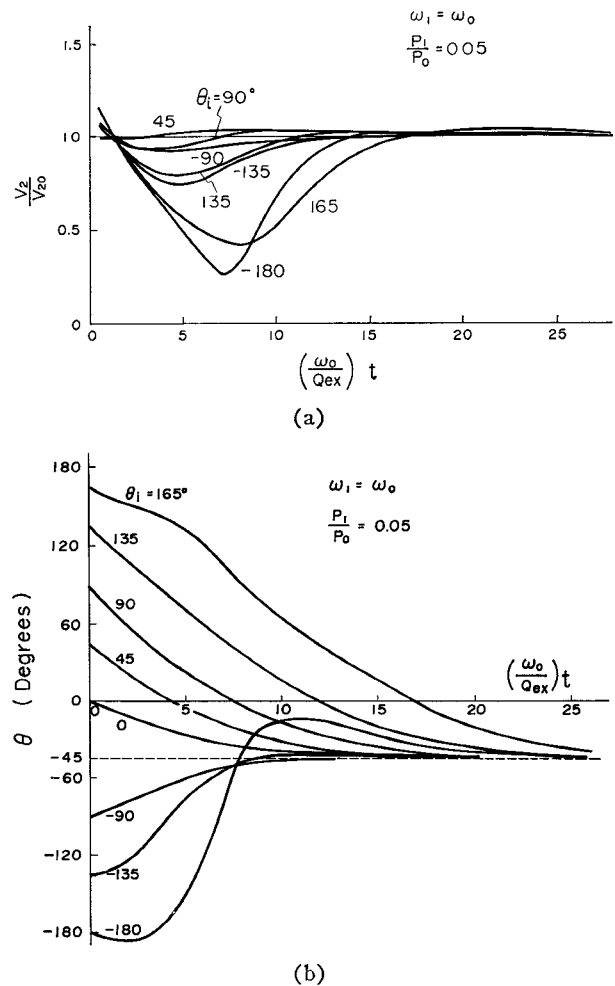


Fig. 3. Transient response of the injection-locked amplifier for injected signals with initial phase offset  $\theta_i$  ( $\omega_1 = \omega_0$ ,  $P_1/P_0 = 0.05$ ). (a) Amplitude transient response. (b) Phase transient response.

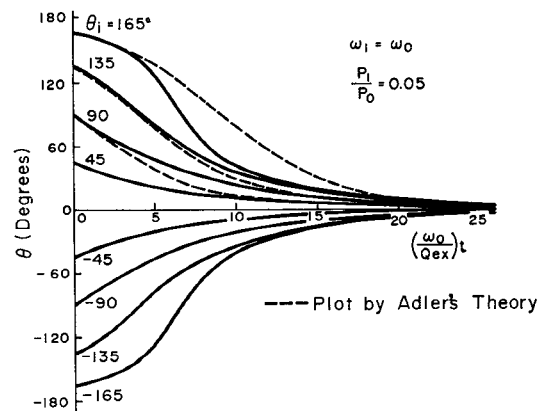


Fig. 4. Phase transient response of the injection-locked amplifier for injected signals with initial phase offset  $\theta_i$  ( $\partial B_1/\partial \tilde{V}_3 = 0$ ,  $\omega_1 = \omega_0$ ,  $P_1/P_0 = 0.05$ ).

and phase converge oscillatorily at carrier frequencies near the upper end of the locking range. In such a situation, when the phase is near its steady-state value, the amplitude is off its steady-state value, and vice versa. The results imply that the optimum frequency condition for PCM-PM signals [5], [12] is affected by the diode admittance nonlinearity.

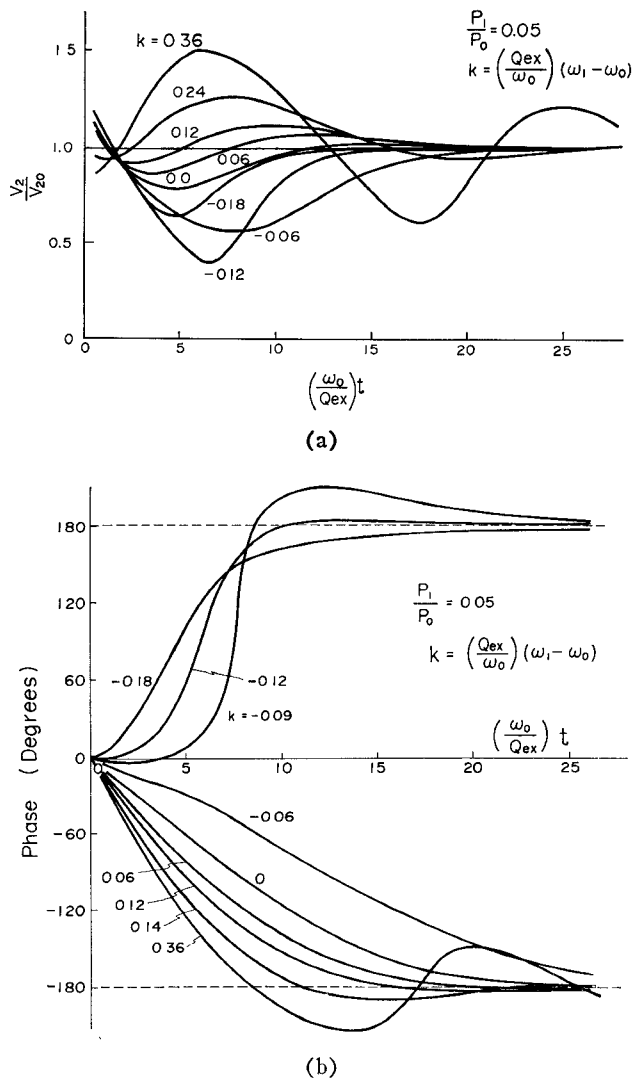


Fig. 5. Transient response of the injection-locked amplifier for injection signals with step phase shift  $\pi(P_1/P_0=0.05)$ . (a) Amplitude transient response. (b) Phase transient response.

### CONCLUSIONS

Dynamic equations of reflection-type nonlinear power amplifiers in both stable and injection-locked modes for modulated signals are derived.

The results of sample calculations indicate that dy-

namic behavior, as well as steady-state behavior, of injection-locked amplifiers is affected by nonlinearity of the diode conductance and susceptance.

The diode susceptance nonlinearity causes hysteresis phenomena to injection-locking characteristics. For an FM signal, modulation conservation rate is maximum when the injected carrier frequency is equal to the free-running frequency, though the diode susceptance nonlinearity is considered. In the transient responses for phase-shift-keyed signals, the nonlinear effects, such as phase transient overshooting and the oscillatory convergence of the amplitude and phase, can be seen.

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